## Update on Collection Efficiency (CE) and Lifetime Measurements

## ERLANGEN CENTRE FOR ASTROPARTICLE PHYSICS

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#### Lifetime data of latest sensors



- Most sensors with ALD coated MCPs have lifetime > 5 C/cm<sup>2</sup>
- 9001393 (2 ALD-layers) at ~ 70 years of PANDA



#### Lifetime data of latest sensors

Lifetime of various MCP-PMTs (400nm)



- Photonis 9002192, 9002193 are at over 6 C/cm<sup>2</sup> without loss unlike 9002108
- Photek A2200606 is at ~3 C/cm<sup>2</sup> and started to drop but later than A1200107 and A3191220

#### Quantum efficiency Photek A2200606

![](_page_3_Picture_1.jpeg)

![](_page_3_Figure_2.jpeg)

![](_page_4_Picture_0.jpeg)

## **Collection efficiency (CE) measurement**

- Reminder:
- CE is probability that a photoelectron creates a signal at the anode (losses due to missing the MCP pore / absorption, ...)
- Measurement of  $CE = N_{pe@anode@15kHz} / N_{pe@PC@15kHz}$  $\rightarrow N_{pe@anode@15kHz} = -\ln(N_{Pedestal}/N_{all})$
- $N_{pe@PC@15kHz}$  can only be measured indirectly:
  - Measure MCPin current using the QE setup at several high laser frequencies
  - Correct for non-linearities in the intensity vs frequency relation of the laser by using a reference diode

 $CE = \frac{N_{pe@anode@15kHz} \cdot e \cdot 50MHz}{I_{PC@50MHz}} \cdot \frac{I_{Diode@50MHz} \cdot 15kHz}{I_{Diode@15kHz} \cdot 50MHz}$ 

![](_page_4_Figure_9.jpeg)

3500

![](_page_5_Picture_0.jpeg)

#### Dependence of CE value on voltage divider configuration

- both gain and number of photoelectrons depend on PC-MCP voltage (energy of initial electron)
- → CE is dependent on PC-MCP voltage

![](_page_5_Figure_4.jpeg)

![](_page_6_Picture_0.jpeg)

#### Dependence of CE value on voltage divider configuration

- CE for different PC-MCP voltages (in both QE and full gain setup) for 9002230 shown below
- slight increase to higher voltages
- below 200V CE drops significantly

9002230

![](_page_6_Figure_6.jpeg)

![](_page_7_Picture_0.jpeg)

#### Dependence of CE value on voltage divider configuration

• different CE at different combinations of PC-MCP voltage and voltage divider configuration:

9002227	200V PC-MCP in QE-Setup	160V PC-MCP in QE-Setup	620V PC-MCP in QE-Setup
1-10-1 in charge spectra setup (160V PC-MCP)	(87+/-2)%	(90+/-1)%	(75+/-1)%
4-10-1 in charge spectra setup (620V PC-MCP)	(113+/-2)%	(116+/-1)%	(97+/-1)%

- previously: always 200V in QE-Setup instead of corresponding PC-MCP voltage as applied in the full setup
  → slightly different (mostly too low) CE (~2-3%)
- better: use of correct voltages
- 4-10-1 instead of 1-10-1 yields slightly higher CE as well (~5%)
- CE measurements now between 95% and 100% instead of ~90% PANDA-Meeting 23/1 March 9, 2023 Daniel Miehling

# Thank you for your attention!

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GEFORDERT VOM

![](_page_8_Picture_3.jpeg)

Bundesministerium für Bildung und Forschung

![](_page_8_Picture_5.jpeg)

![](_page_8_Picture_6.jpeg)

![](_page_8_Picture_7.jpeg)

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